

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination LI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Full, formal English translation of JP 2000-63433 (Iwasa et al), provided by USPTO.
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